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APPLICATION NO.	FILING DATE		FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/003,982	10/30/2001		Robert Varney		6027	
7	590	03/22/2004		EXAM	EXAMINER	
Legal Department				DIMYAN, MAGID Y		
Teradyne, Inc. 321 Harrison A	venue			ART UNIT	PAPER NUMBER	
Boston, MA 02118				2825	-	
				DATE MAILED: 03/22/2004	4	

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)	
	10/003,982	VARNEY, ROBERT	
Office Action Summary	Examiner	Art Unit	
	Magid Y Dimyan	2825	
The MAILING DATE of this communication a Period for Reply	ppears on the cover sheet w	ith the correspondence address -	
A SHORTENED STATUTORY PERIOD FOR REP THE MAILING DATE OF THIS COMMUNICATION - Extensions of time may be available under the provisions of 37 CFR after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a re - If NO period for reply is specified above, the maximum statutory perion - Failure to reply within the set or extended period for reply will, by state Any reply received by the Office later than three months after the main earned patent term adjustment. See 37 CFR 1.704(b).	I. 1.136(a). In no event, however, may a eply within the statutory minimum of thind will apply and will expire SIX (6) MO ute, cause the application to become A	reply be timely filed ty (30) days will be considered timely. NTHS from the mailing date of this communications (35 U.S.C. § 133).	ation.
Status			
1)⊠ Responsive to communication(s) filed on 19 2a)⊠ This action is FINAL. 2b)□ The 3)□ Since this application is in condition for allow closed in accordance with the practice under	nis action is non-final. vance except for formal mat	•	s is
Disposition of Claims			
4) ⊠ Claim(s) 24-27,32-35 and 37-44 is/are pendid 4a) Of the above claim(s) is/are withdrest is/are withdrest is/are allowed. 6) ⊠ Claim(s) 24-27,32-35 and 37-44 is/are reject is/are objected to. 7) □ Claim(s) is/are object to restriction and is/are subject to restriction and is/are subject.	ed.		
Application Papers			
9) ☐ The specification is objected to by the Examin 10) ☑ The drawing(s) filed on 11 March 2002 is/are Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) ☐ The oath or declaration is objected to by the	: a)⊠ accepted or b)☐ ob the drawing(s) be held in abeya the processor is required if the drawing	nce. See 37 CFR 1.85(a). (s) is objected to. See 37 CFR 1.12	• •
Priority under 35 U.S.C. § 119			
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of: 1. Certified copies of the priority docume 2. Certified copies of the priority docume 3. Copies of the certified copies of the priority docume application from the International Bure * See the attached detailed Office action for a list	nts have been received. nts have been received in A iority documents have beer au (PCT Rule 17.2(a)).	Application No received in this National Stage	
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/0	Paper No	Summary (PTO-413) s)/Mail Date nformal Patent Application (PTO-152)	

DETAILED ACTION

Acknowledgement

1. Receipt is acknowledged of the Amendment to the Claims, as well as the Remarks, filed 19 December 2003. It is also acknowledged that the Applicant has cancelled claims 28-31, 36 and 45 – 54.

Claim Objections

- 2. Claim 24 is objected to because of the following informalities: line 24, recites an ATPG/scan fail translator, however it has not been previously mentioned or described, nor has it been referred to in the Specification. Appropriate action is required.
- 3. Claim 39, line 3, delete "and"; line 4, delete "comprises" and insert --comprising--. Appropriate action is required.

Claim Rejections - 35 USC § 103

4. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

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(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

- 5. Claims 24 27, 32 35 and 37 44 are rejected under 35 U.S.C. 103(a) as being unpatentable over U.S. Patent No. 6,185,707 to Smith et al (hereinafter, Smith) in view of U.S. Patent No. 6,205,407 to Testa et al (hereinafter, Testa).
- 6. Referring to claims 24 and 35, Smith discloses a DFT result diagnosis method and system as claimed herein, that includes (a) an ATE data source; (b) an ATPG tool to generate ATPG pattern data; (c) at least one translation module; and (d) means to summarize test result data. See Figs. 11, 12; column 3, lines 1 – 12. The only limitations not recited by Smith are the use of a Graphical User Interface (GUI) or other graphical means of displaying the results. However, Testa teaches a system and method for generating test code for testing an IC on an ATE platform that includes translating scan and pattern data into test code that make use of a GUI in his invention (see Abstract; Summary of the Invention, column 2, lines 25 – 56). As per claim 25, see Smith, Fig. 12; column 1, lines 11 – 43, which cite using a semiconductor tester. As per claims 26 and 27, see Figs. 11 and 12, which show the ATE data source, as well as the translation modules and mapping generator claimed herein. As for claims 32 – 34, as mentioned above Smith discloses the DFT result diagnosis system that includes a tester, scan diagnosis tool, translation module to convert data between domains, and means for storing test result data. Furthermore, Smith cites how the X, Y coordinates of the failed

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chains are obtained (see Abstract; column 3, lines 35 – 62). Again, as mentioned above, Testa recites the use of a GUI in his invention. As for claims 37 and 38, see above, as well as the Abstract, which teach how the X-Y coordinates of a failed net (i.e., a failed scan chain) can be identified and displayed, so that they can be easily diagnosed, as claimed. Referring to claims 39 – 43, see also Fig. 12; and the Abstract, which recite the steps of device testing as claimed. As per claim 44, see column 4, lines 61 – 65 and Fig. 3, which show how scan failures are displayed, as claimed.

7. Since GUI's and other graphics would greatly facilitate and enhance the scan diagnosis process, and are now well known in the art of IC design and development, it would therefore be obvious to one having ordinary skill in the art at the time the invention was made to combine the teachings of Smith and Testa to obtain the same inventions as claimed herein.

Response to Amendment

8. In response to the Remarks by the Applicant referred to above in the Acknowledgement, the Smith disclosure relates to DFT techniques (column 1, lines 9 – 21) as well as ATE. The Examiner has not cited Testa for these limitations, as argued by the Applicant. Smith performs a diagnosis step wherein a list of failed scan chains is displayed (column 4, lines 35 – 42) on a display device (see also Fig. 10), which necessarily includes a graphical user interface (see Testa, Abstract). Smith does indeed

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correlate these test failures to physical defects for bitmapping purposes, but this cannot discount the fact that Smith also suggests Applicant's claim language of identifying the locations of failed scan chain data.

9. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Magid Y Dimyan whose telephone number is (571) 272-1889. The examiner can normally be reached on Monday - Friday 8:00 AM - 5:00 PM.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Matthew S Smith can be reached on (571) 272-1907. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

myd

Magid Y Dimyan

Examiner

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PLIMARY EXAMIDER
SCHOOLDGY COSTER 2800